

AUIRF2903ZS-VB Datasheet N-Channel 30 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	30
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 V$	0.0014
$R_{DS(on)}(\Omega)$ at $V_{GS} = 4.5 V$	0.0016
I _D (A)	260
Configuration	Single

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- Package with Low Thermal Resistance

D

- 100 % $R_{\rm q}$ and UIS Tested

GC

• Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S (T _C = 25 °C, unles	s otherwise noted	ł)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	30	V
Gate-Source Voltage		V _{GS}	± 20	v
Continuous Drain Current	T _C = 25 °C	1	260	
Continuous Drain Current	T _C = 125 °C	I _D	120 ^a	
Continuous Source Current (Diode Conduction	on) ^a	I _S	120	А
Pulsed Drain Current ^b		I _{DM}	680	
Single Pulse Avalanche Current		I _{AS}	82	
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	336	mJ
Maximum Dawar Dissinction	T _C = 25 °C	P	375	W
Maximum Power Dissipation ^b	T _C = 125 °C	P _D	125	vv
Operating Junction and Storage Temperatur	e Range	T _J , T _{stg}	- 55 to + 175	°C

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount ^c	R _{thJA}	40	°C/W
Junction-to-Case (Drain)		R _{thJC}	0.4	0/10

Notes

a. Package limited.

b. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

c. When mounted on 1" square PCB (FR-4 material).

d. Parametric verification ongoing.

B	Network Notes National Network
www.V	Bsemi.com

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	1			•		•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	30	-	-	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	- V _{GS} , I _D = 250 μΑ	1.5	2.0	2.5	V
Gate-Source Leakage	I _{GSS}	V _{DS} =	0 V, $V_{GS} = \pm 20 V$	-	-	± 100	nA
		$V_{GS} = 0 V$	V _{DS} = 30 V	-	-	1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	$V_{DS} = 30 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	50	μA
		$V_{GS} = 0 V$	V _{DS} = 30 V, T _J = 175 °C	-	-	250	1
On-State Drain Current ^a	I _{D(on)}	V _{GS} = 10 V	$V_{DS} \ge 5 V$	120	-	-	Α
		$V_{GS} = 10 V$	I _D = 30 A	-	0.0014	-	
		V _{GS} = 10 V	I _D = 30 A, T _J = 125 °C	-	0.0023	-	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A, T _J = 175 °C	-	0.0028	-	Ω
		V _{GS} = 4.5 V	I _D = 20 A	-	0.0016	-	1
Forward Transconductance ^b	g fs	V _{DS}	= 15 V, I _D = 30 A	-	190	-	S
Dynamic ^b					•		
Input Capacitance	C _{iss}			-	12 484	15 605	
Output Capacitance	C _{oss}	$V_{GS} = 0 V$	V _{DS} = 15 V, f = 1 MHz	-	2204	2755	pF
Reverse Transfer Capacitance	C _{rss}			-	860	1075	1
Total Gate Charge ^c	Qg			-	179	270	
Gate-Source Charge ^c	Q _{gs}	$V_{GS} = 10 V$	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 120 \text{ A}$	-	34	-	nC
Gate-Drain Charge ^c	Q _{gd}			-	21	-	1
Gate Resistance	R _g		f = 1 MHz	0.59	1.19	1.79	Ω
Turn-On Delay Time ^c	t _{d(on)}			-	18	27	
Rise Time ^c	t _r	- V=	= 15 V, R _I = 0.3 Ω	-	11	17	1
Turn-Off Delay Time ^c	t _{d(off)}	$I_D \cong 50 \text{ A},$	-	64	96	ns	
Fall Time ^c	t _f	1		-	11	17	1
Source-Drain Diode Ratings and Char	acteristics ^b	•					
Pulsed Current ^a	I _{SM}			-	-	480	A
Forward Voltage	V _{SD}	IF =	60 A, V _{GS} = 0 V	-	0.81	1.5	V

Notes

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

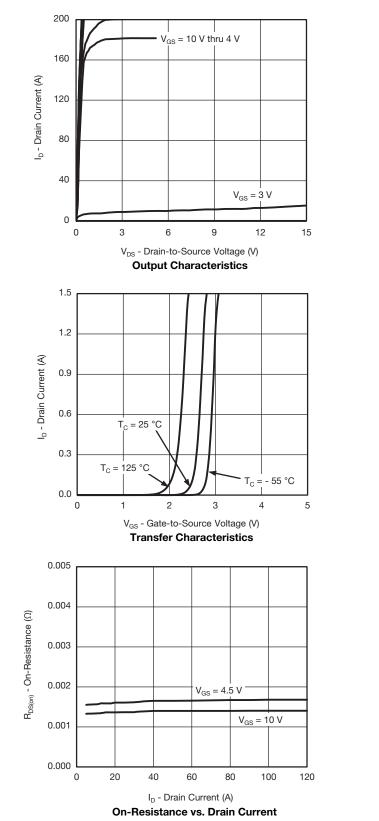
b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

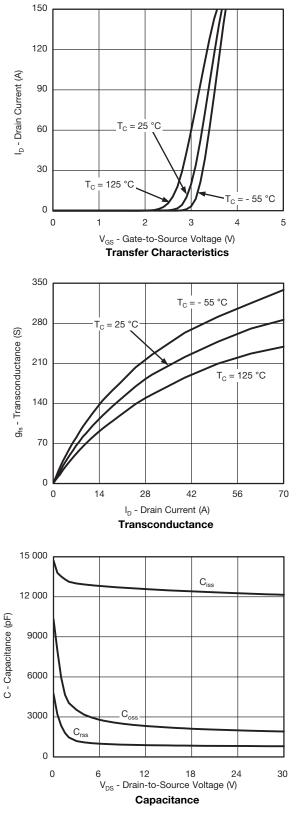
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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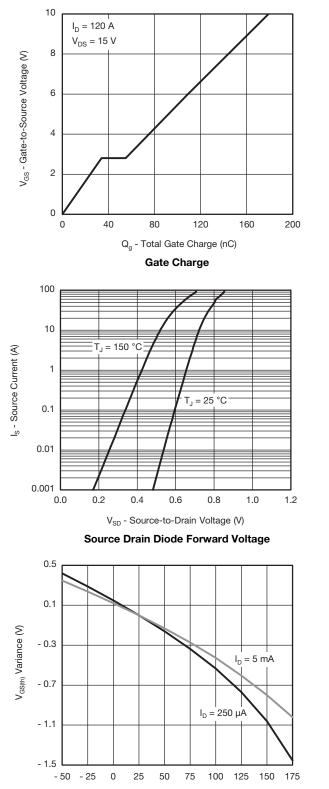




TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)

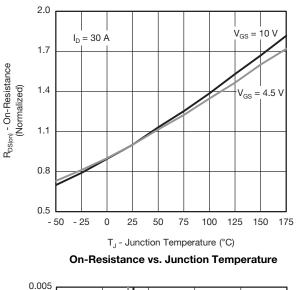


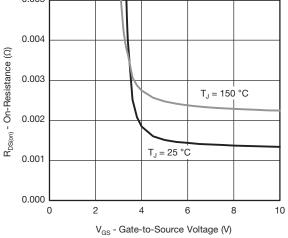




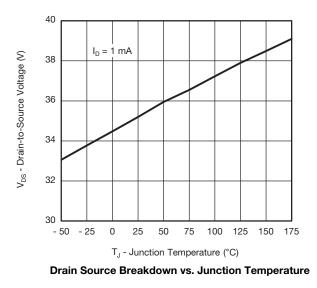
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

T_J - Temperature (°C) Threshold Voltage





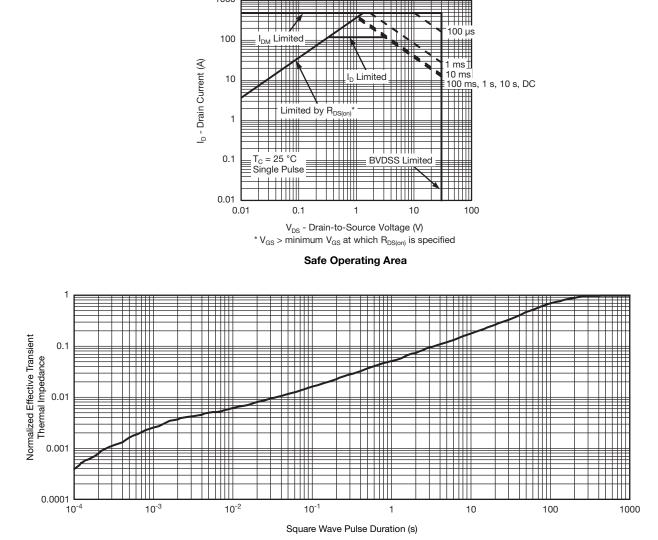
On-Resistance vs. Gate-to-Source Voltage





THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)

1000

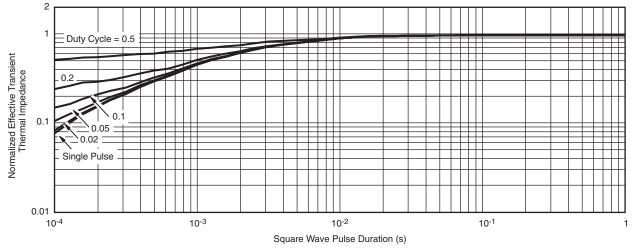


Normalized Thermal Transient Impedance, Junction-to-Ambient

AUIRF2903ZS-VB



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

Note

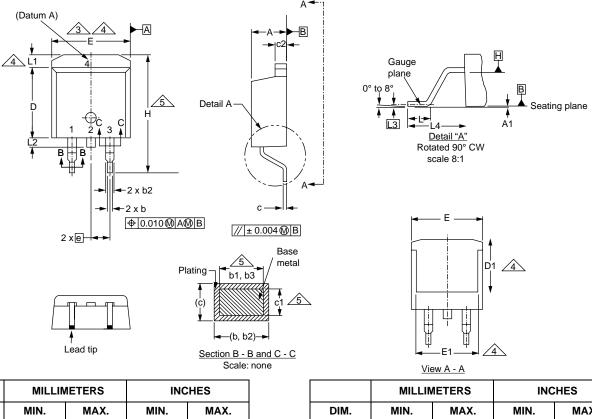
The characteristics shown in the two graphs •

- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-263AB (HIGH VOLTAGE)



DIM.	MIN.	MAX.	MIN.	MAX.
А	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380
CN: S-82 WG: 597	110-Rev. A, 0	15-Sep-08		

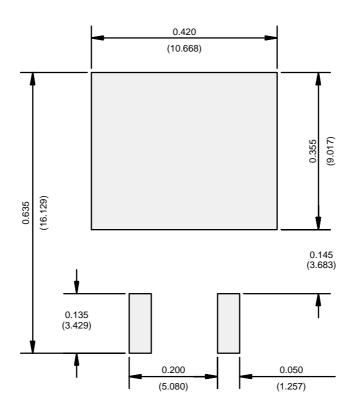
Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.



RECOMMENDED MINIMUM PADS FOR D PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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